SGM44599

GENERAL DESCRIPTION

The SGM44599 is a high-speed, low-voltage, advanced dual-independent double-pole/double-throw (DPDT) CMOS analog switch that is designed to operate from a single +1.8V to +5.5V power supply. It features high-bandwidth (300MHz) and low on-resistance (4 Ω TYP), targeted applications for audio switching.

The SGM44599 is configured as a dual double-pole /double-throw (DPDT) device with two logic control inputs that control two multiplexer/demultiplexers each. The configuration can also be used as a dual differential 2-to-1 multiplexer/ demultiplexer.

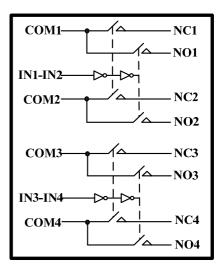
SGM44599 is available in TQFN-16 (3mm × 3mm) and TQFN-16 (2.5mm × 2.5mm) packages.

4Ω, High Speed, Low Voltage Dual, DPDT Analog Switch

FEATURES

- Low Voltage Operation: 1.8V to 5.5V
- On-Resistance: 4Ω (TYP)
- Low On-Resistance Flatness
- 3dB Bandwidth: 300MHz
- Rail-to-Rail Input and Output Operation
- High Off-Isolation: -75dB at 1MHz
- Low Crosstalk: -100dB at 1MHz
- Typical Power Consumption (<0.01 μW)
- TTL/CMOS Compatible
- Lead (Pb) Free TQFN-16 (3mm × 3mm) and TQFN-16 (2.5mm × 2.5mm) Packages
- Extended Industrial Temperature Range: -40°C to +85°C

BLOCK DIAGRAM



APPLICATIONS

Communication Systems Cell Phones Portable Instrumentation Audio Signal Routing Audio and Video Switching PCMCIA Cards Computer Peripherals Modems PDAs

SG Micro Limited www.sg-micro.com

ORDERING INFORMATION

MODEL	PIN- PACKAGE	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE MARKING	PACKAGE OPTION
SGM44599	TQFN-16 (2.5mm×2.5mm)	-40°C to +85°C	SGM44599YTQB16/TR	44599	Tape and Reel, 3000
	TQFN-16 (3mm×3mm)	-40°C to +85°C	SGM44599YTQ16/TR	44599	Tape and Reel, 3000

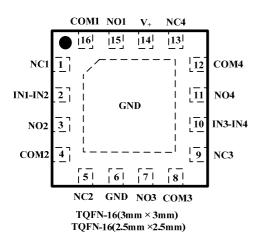
ABSOLUTE MAXIMUM RATINGS

V+ to GND	-0.3V to +6V
Analog, Digital voltage range	0.3V to (V++ 0.3V)
Continuous Current NO, NC, or COM	±150mA
Peak Current NO, NC, or COM	±200mA
Operating Temperature Range	40°C to +85°C
Junction Temperature	+150°C

Storage Temperature	65°C to +150°C
Lead Temperature (soldering, 10s)	260°C
ESD Susceptibility	
HBM	2000V
MM	200V

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

PIN CONFIGURATIONS (TOP VIEW)



FUNCTION TABLE

IN1-IN2	Function			
1111-1112	NC1 and NC2	NO1 and NO2		
0	ON	OFF		
1	OFF	ON		

IN3-IN4	Function			
1105-1104	NC3 and NC4	NO3 and NO4		
0	ON	OFF		
1	OFF	ON		

PIN DESCRIPTION

]				
NAME	TQFN-16 (3mm×3mm)	TQFN-16 (2.5mm×2.5mm)	FUNCTION		
V+	(011111 011111)	14	Power supply		
GND	6		Ground		
INx	2,10		Digital control pin to connect the COM terminal to the NO or NC terminals		
COMx	16,4, 8, 12		Common terminal		
NOx	15,3	3, 7, 11	Normally-open terminal		
NCx	1,5	5, 9, 13	Normally-closed terminal		

Note: NOx, NCx and COMx terminals may be an input or output.

ELECTRICAL CHARACTERISTICS

 $(V_{+} = +4.5V \text{ to } +5.5V, \text{ GND} = 0V, V_{IH} = +1.6V, V_{IL} = +0.5V, T_{A} = -40^{\circ}\text{C} \text{ to } +85^{\circ}\text{C}$. Typical values are at $V_{+} = +5.0V$, $T_{A} = +25^{\circ}\text{C}$, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS		TEMP	MIN	TPY	MAX	UNITS
ANALOG SWITCH				•				
Analog Signal Range	VNO, VNC, VCOM			-40°C to +85°C	0		V+	V
Ora Descistant en	$V_{+} = 4.5V, 0V \le V_{NO} \text{ or } V_{NC} \le V_{+},$		+25°C		4	6.2	Ω	
On-Resistance	Ron	Iсом = -100mA, Test Circui	Iсом = -100mA, Test Circuit 1				7.2	Ω
On-Resistance Match Between	ΔRon	$V_{+} = 4.5V, 0V \le V_{NO} \text{ or } V_{NC} \le V_{+},$		+25°C		0.4	2.6	Ω
Channels	AKON	Iсом = -100mA, Test Circui	t 1	-40°C to +85°C			3.1	Ω
On-Resistance Flatness	Rflat(on)	$V_{\pm} = 4.5V, 0V \le V_{NO} \text{ or } V_{NC}$,	+25°C		2	3.1	Ω
	RFLAT(ON)	Iсом = -100mA, Test Circui	t 1	-40°C to +85°C			3.6	Ω
Source OFF Leakage Current	INC(OFF), INO(OFF)	V+=5.5V, Vno or Vnc=3.3V Vcom=0.3V/ 3.3V		-40°C to +85°C			1	μΑ
Channel ON Leakage Current	Inc(on), Ino(on), Icom(on)	V+= 5.5V, V _{COM} = 0.3V/ 3.3V, V _{NO} or V _{NC} = 0.3V/ 3.3V, or floating		-40°C to +85°C			1	μΑ
DIGITAL INPUTS						•		
Input High Voltage	Vinh			-40°C to +85°C	1.6			V
Input Low Voltage	Vinl			-40°C to +85°C			0.5	V
Input Leakage Current	Iin	$V_{+} = 5.5V$, $V_{IN} = 0V$ or $5.5V$		-40°C to +85°C			1	μΑ
DYNAMIC CHARACTERISTIC	CS							
Turn-On Time	ton	$V_{NC} \text{ or } V_{NO} = 3.0 \text{V}, \text{ RL} = 300$)Ω,	+25°C		31.5		ns
Turn-Off Time	toff	CL = 35pF, Test Circuit2		+25°C		30.0		ns
Break-Before-Make Time Delay	t⊳	V _{NC} or V _{NO} = 3.0V, R _L = 300Ω, C _L = 35pF, Test Circuit4		+25°C		11.5		ns
Charge Injection	Q	$V_G = GND, R_G = 0\Omega, C_L = 1$ $Q = C_L \times V_{OUT}, Test Circuit$		+25°C		3.5		pC
Off Isolation	Oiso	Signal = 0dBm, R_L = 50 Ω , Test Circuit5	1MHz	+25°C		-75		dB
On isolation	Olso		10MHz	+25°C		-55		uв
Channel-to-Channel Crosstalk	Xtalk	Signal = $0dBm_R = 50\Omega_r$	1MHz	+25°C		-100		dB
Channel-to-Channel Crosstark	AIALK	Test Circuit6	10MHz	+25°C		-60		uв
-3dB Bandwidth	BW	Signal = 0 dBm, RL = 50Ω , Test Circuit7		+25°C		300		MHz
Channel ON Capacitance	CNC(ON), CNO(ON), CCOM(ON)			+25°C		43.2		pF
POWER REQUIREMENTS								
Power Supply Range	V+			-40°C to +85°C	1.8		5.5	V
Power Supply Current	I+	$V_{+} = 5.5V$, $V_{IN} = 0V$ or V_{+}		-40°C to +85°C			1	μΑ

Specifications subject to changes without notice.

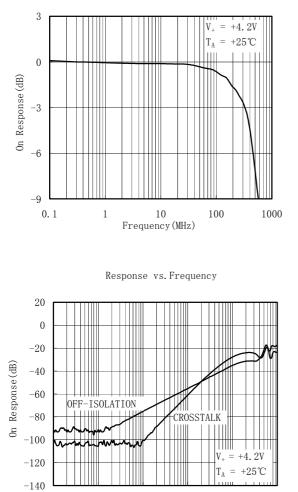
ELECTRICAL CHARACTERISTICS

 $(V_{+} = +2.7V \text{ to } +3.6V, V_{IH} = +1.6V, V_{IL} = +0.4V, T_{A} = -40^{\circ}C \text{ to } +85^{\circ}C.$ Typical values are at $V_{+} = +3.0V$, $T_{A} = +25^{\circ}C$, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS		TEMP	MIN	TPY	MAX	UNITS
ANALOG SWITCH								
Analog Signal Range	VNO, VNC, VCOM			-40°C to +85°C	0		V+	V
On Desistance	D	$V_{+} = 2.7V, 0V \le V_{NO} \text{ or } V_{NC} \le V_{+},$		+25°C		10	15	Ω
On-Resistance	Ron	Iсом = -100mA, Test Circui	it 1	-40°C to +85°C			18	Ω
On-Resistance Match Between	AD	$V_{+} = 2.7V, 0V \le V_{NO} \text{ or } V_{NO}$	≤ V+,	+25°C		1	3	Ω
Channels	ΔR on	Iсом = -100mA, Test Circuit 1		-40°C to +85°C			4	Ω
On-Resistance Flatness	D	$V_{+} = 2.7V, 0V \le V_{NO} \text{ or } V_{NC} \le V_{+},$		+25°C		6	9	Ω
On-Resistance Flatness	$R_{FLAT(ON)}$	Iсом = -100mA, Test Circui	it 1	-40°C to +85°C			12	Ω
Source OFF Leakage Current	INC(OFF), INO(OFF)	V+= 3.6V, VNO or VNC= 3.3V / 0.3V, VCOM= 0.3V/ 3.3V		-40°C to +85°C			1	μΑ
Channel ON Leakage Current	Inc(on), Ino(on), Icom(on)	V+= 3.6V, V _{COM} = 0.3V/ 3.3V, V _{NO} or V _{NC} = 0.3V/ 3.3V, or floating		-40°C to +85°C			1	μΑ
DIGITAL INPUTS								
Input High Voltage	Vinh			-40°C to +85°C	1.5			V
Input Low Voltage	Vinl			-40°C to +85°C			0.4	V
Input Leakage Current	Iin	$V_{+}=2.7V$, $V_{IN}=0V$ or 2.7V		-40°C to +85°C			1	μΑ
DYNAMIC CHARACTERISTIC	CS							
Turn-On Time	ton	$V_{\rm NC} \text{ or } V_{\rm NO} = 1.5 V, R_{\rm L} = 300 \Omega,$		+25°C		38.0		ns
Turn-Off Time	toff	CL = 35pF, Test Circuit2		+25°C		44.0		ns
Break-Before-Make Time Delay	t⊳	V _{NC} or V _{NO} = 1.5V, R _L = 300 C _L = 35pF, Test Circuit4)Ω,	+25°C		5.8		ns
Charge Injection	Q	$V_G = GND, R_G = 0\Omega, C_L = 1.0nF,$ $Q = C_L \times V_{OUT}$, Test Circuit3		+25°C		2.6		pC
Off Isolation	Oiso	Signal = 0dBm, R_L = 50 Ω , Test Circuit5	1MH	+25°C		-75		dB
			10MHz	+25°C		-55		dB
Channel-to-Channel Crosstalk	Xtalk	Signal = 0dBm, $R_L = 50\Omega$,1MHzTest Circuit610MHz	1MHz	+25°C		-100		dB
			10MHz	+25°C		-60		dB
-3dB Bandwidth	BW	Signal = 0 dBm, RL = 50Ω , Test Circuit7		+25°C		300		MHz
Channel ON Capacitance	CNC(ON), CNO(ON), CCOM(ON)			+25°C		43.2		pF

Specifications subject to changes without notice.

TYPICAL PERFORMANCE CHARACTERISTICS



10

1

Frequency(MHz)

100

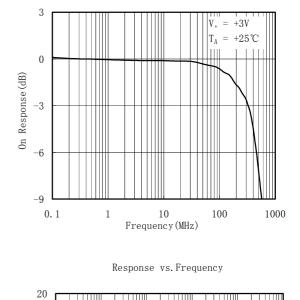
1000

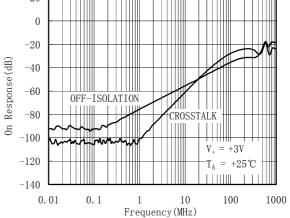
0.01

0.1

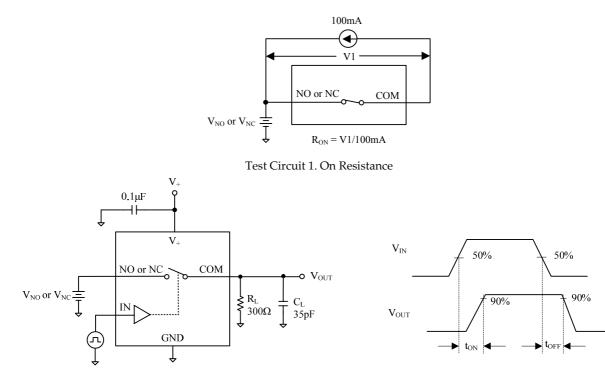
On Response vs. Frequency

On Response vs. Frequency

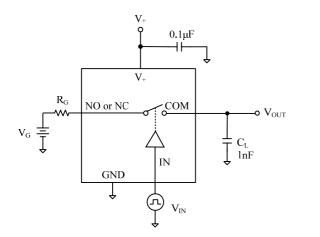


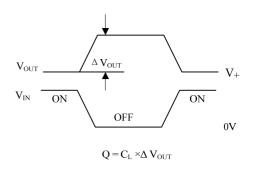


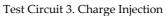
TEST CIRCUITS





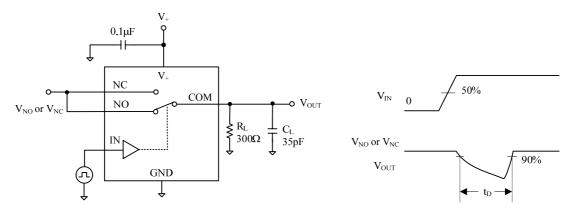


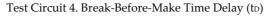


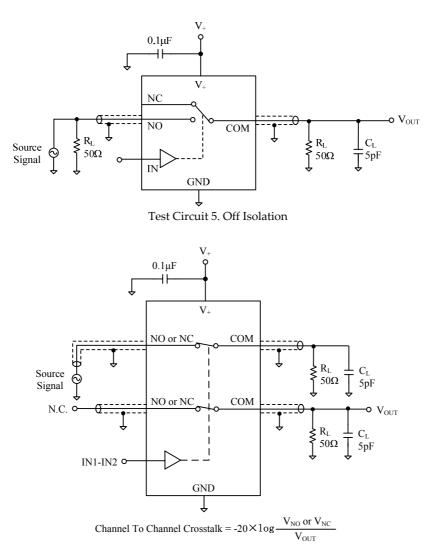


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TEST CIRCUITS (Cont.)



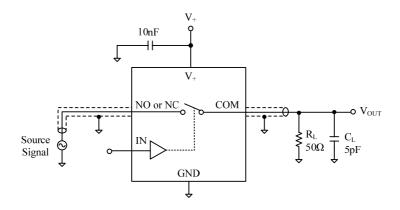






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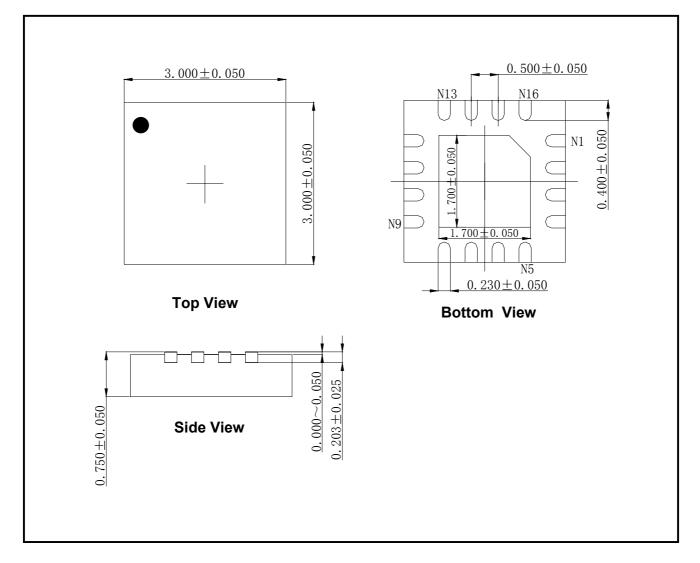
TEST CIRCUITS (Cont.)



Test Circuit 7. -3dB Bandwidth

PACKAGE OUTLINE DIMENSIONS

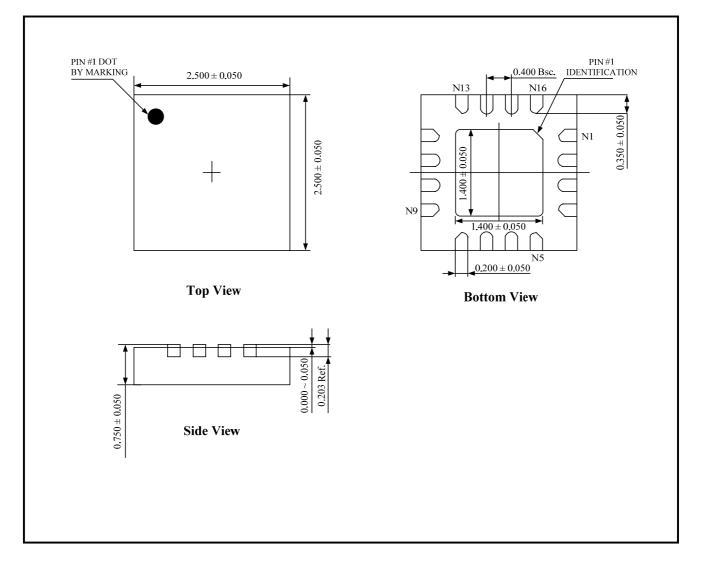
TQFN-16 (3mm × 3mm)



Note: All linear dimensions are in millimeters.

PACKAGE OUTLINE DIMENSIONS

TQFN-16 (2.5mm × 2.5mm)



Note: All linear dimensions are in millimeters.

REVISION HISTORY

10/2007-Preliminary Datasheet

Location

Page



SGMICRO is dedicated to provide high quality and high performance analog IC products to customers. All SGMICRO products meet the highest industry standards with strict and comprehensive test and quality control systems to achieve world-class consistency and reliability.

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